Application/Control No. Applicant(s)/Patent Under Reexamination 10/634,385 IKEDA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2821 Hoang V Nguyen **U.S. PATENT DOCUMENTS Document Number** Date · Classification Name Country Code-Number-Kind Code MM-YYYY US-2002/0118140 A1 343/834 08-2002 Ogawa et al. Α 343/725 US-6,181,286 B1 01-2001 Roscoe et al. В US-С US-D Ε US-US-F G US-US-Н US-J US-Κ US-L US-US-FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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